

Search Notes**Application/Control No.**

09/821,664

Examiner

John L. Shew

Applicant(s)/Patent under Reexamination

XU ET AL.

Art Unit

2664

SEARCHED

Class	Subclass	Date	Examiner
370	229	8/3/2005	JS
	230-237		
	252,389		
	395.53		
	397		
	400-401		
	411-412		
	468		
709	226,251	8/3/2005	JS

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner